

# Half-Bridge IPM for Small Appliance **Motor Drive Applications**



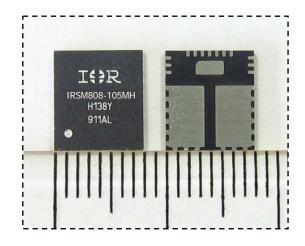
10A, 500V

#### **Description**

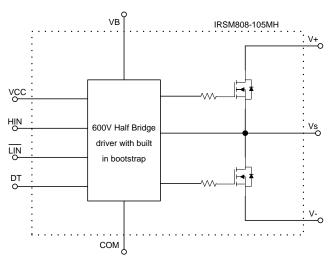
IRSM808-105MH is a 10A, 500V half-bridge module designed for advanced appliance motor drive applications such as energy efficient fans and pumps. IR's technology offers an extremely compact, high performance half-bridge topology in an isolated package. This advanced IPM offers a combination of IR's low R<sub>DS(on)</sub> Trench FREDFET technology and the industry benchmark half-bridge high voltage, rugged driver in a small PQFN package. At only 8x9mm and featuring integrated bootstrap functionality, the compact footprint of this surface-mount package makes it suitable for applications that are space-constrained. IRSM808-105MH functions without a heat sink.

#### **Features**

- Integrated gate drivers and bootstrap functionality
- Suitable for sinusoidal modulation applications
- Low R<sub>DS(on)</sub> Trench FREDFET
- Under-voltage lockout for both channels
- Matched propagation delay for all channels
- Optimized dV/dt for loss and EMI trade offs
- 3.3V input logic compatible
- · Active high HIN and active low LIN
- Motor Power range 80-200W
- Isolation 1500V<sub>RMS</sub> min
- ROHS compliant



#### **Internal Electrical Schematic**



**Ordering Information** 

Orderable Part Number	Package Type	Form	Quantity	
IRSM808-105MH	PQFN 8x9mm	Tray	1300	
IRSM808-105MHTR	PQFN 8x9mm	Tape and Reel	2000	



#### **Absolute Maximum Ratings**

Absolute maximum ratings indicate sustained limits beyond which damage to the module may occur. These are not tested at manufacturing. All voltage parameters are absolute voltages referenced to V<sub>SS</sub> unless otherwise stated in the table. The thermal resistance rating is measured under board mounted and still air conditions.

Symbol	Description	Min	Max	Unit
BV <sub>DSS</sub>	MOSFET Blocking Voltage		500	٧
Io	Output DC Current per MOSFET @ T <sub>C</sub> =25°C		10	Α
P <sub>d</sub>	Power dissipation per MOSFET @ T <sub>C</sub> =100°C		55	W
T <sub>J</sub> (MOSFET & IC)	Maximum Operating Junction Temperature		150	°C
T <sub>L</sub>	Lead temperature (soldering 30 seconds)		260	°C
Ts	Storage Temperature Range	-40	150	°C
V <sub>B</sub>	High side floating supply voltage	-0.3	VS + 20	V
Vs	High side floating supply offset voltage	VB - 20	VB +0.3	V
V <sub>CC</sub>	Low Side fixed supply voltage	-0.3	20	V
V <sub>IN</sub>	Logic input voltage LIN, HIN	-0.3	VCC+0.3	V
V <sub>ISO</sub>	Isolation voltage (1min) (Note2)		1500	V <sub>RMS</sub>

Note1: Calculated based on maximum junction temperature. Bond wires current limit is 3.5A. Note2: Characterized, not tested at manufacturing

**Recommended Operating Conditions** 

Symbol	Description	Min	Тур	Max	Units	Conditions
V <sup>+</sup>	Positive DC Bus Input Voltage		-	400	V	
V <sub>S1,2,3</sub>	High Side Floating Supply Offset Voltage	(Note 3)	-	400	V	
V <sub>B1,2,3</sub>	High Side Floating Supply Voltage	V <sub>S</sub> +12		V <sub>S</sub> +20	V	
V <sub>CC</sub>	Low Side and Logic Supply Voltage	13.5		16.5	V	
V <sub>IN</sub>	Logic Input Voltage	СОМ		V <sub>CC</sub>	V	
Fp	PWM Carrier Frequency			20	kHz	

For proper operation the module should be used within the recommended conditions. All voltages are absolute referenced to COM. The V<sub>S</sub> offset is tested with all supplies biased at 15V differential.

Note 3: Logic operational for V<sub>s</sub> from COM-8V to COM+500V. Logic state held for V<sub>s</sub> from COM-8V to COM-V<sub>BS</sub>.



#### **Static Electrical Characteristics**

V<sub>BIAS</sub> (V<sub>CC</sub>, V<sub>BS</sub>)=15V, T<sub>J</sub>=25°C, unless otherwise specified. The V<sub>IN</sub>, and I<sub>IN</sub> parameters are referenced to COM

Symbol	Description	Min	Тур	Max	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	500			V	T <sub>J</sub> =25°C, I <sub>LK</sub> =3mA
I <sub>LKH</sub>	Leakage Current of High Side FET's in Parallel		15		μА	T <sub>J</sub> =25°C, V <sub>DS</sub> =500V
I <sub>LKL</sub>	Leakage Current of Low Side FET's in Parallel Plus Gate Drive IC		20		μА	T <sub>J</sub> =25°C, V <sub>DS</sub> =500V
			0.58	0.8		T <sub>J</sub> =25°C, V <sub>CC</sub> =10V, Id = 6A
R <sub>DS(ON)</sub>	Drain to Source ON Resistance		1.60		Ω	$T_J=150^{\circ}C$ , $V_{CC}=10V$ , $Id=6A$ (Note 4)
$V_{SD}$	Diode Forward Voltage		0.85	1.0	V	$T_J=25$ °C, $V_{CC}=10$ V, $Id=6A$
V <sub>HIN/LIN</sub>	Logic "1" input voltage for HIN & "0" for LIN	2.2			V	
V <sub>HIN/LIN</sub>	Logic "0" input voltage for HIN & "1" for LIN	-		0.8	V	
V <sub>CCUV+</sub> , V <sub>BSUV+</sub>	V <sub>CC</sub> and V <sub>BS</sub> Supply Under-Voltage, Positive Going Threshold	8	8.9	9.8	V	
$V_{\text{CCUV-}}, V_{\text{BSUV-}}$	V <sub>CC</sub> and V <sub>BS</sub> supply Under-Voltage, Negative Going Threshold	7.4	8.2	9.0	V	
$V_{\text{CCUVH}}, V_{\text{BSUVH}}$	V <sub>CC</sub> and V <sub>BS</sub> Supply Under-Voltage Lock- Out Hysteresis		0.7		V	
$I_{QBS}$	Quiescent V <sub>BS</sub> Supply Current V <sub>IN</sub> =0V		45	70	μΑ	
Iqcc	Quiescent V <sub>CC</sub> Supply Current V <sub>IN</sub> =0V		1100	3000	μΑ	
I <sub>HIN+</sub>	Input Bias Current V <sub>IN</sub> =4V		5	20	μΑ	
I <sub>LIN-</sub>	Input Bias Current V <sub>IN</sub> =0V		1	2	μΑ	
R <sub>BR</sub>	Internal Bootstrap Equivalent Resistor Value		200		Ω	T <sub>J</sub> =25°C

Note 4: Characterized, not tested at manufacturing

#### **MOSFET Avalanche Characteristics**

Symbol	Description		Min Typ		Units	Conditions	
EAS	Single Pulse Avalanche Energy		216		mJ	T <sub>J</sub> =25°C, L=3mH, VDD=100V, IAS=12A, TO-220 package.	

## **Dynamic Electrical Characteristics**

V<sub>BIAS</sub> (V<sub>CC</sub>, V<sub>BS</sub>)=15V, TJ=25°C, unless otherwise specified. Driver only timing unless otherwise specified.

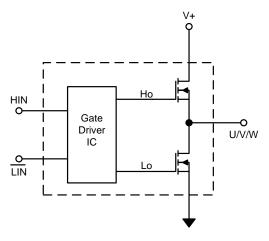
Symbol	Description	Min	Тур	Max	Units	Conditions	
Ton	Input to Output Propagation Turn-On Delay Time		0.8	1.3	μs	I <sub>D</sub> =1mA, V <sup>+</sup> =50V	
T <sub>OFF</sub>	Input to Output Propagation Turn-Off Delay Time		0.8	1.3	μs	Gate Driver; V <sub>LIN</sub> =0 & V <sub>HIN</sub> =5V	
DT	Built-in Deadtime	0.9	1.3		μs	with no external deadtime	
T <sub>FIL,IN</sub>	Input Filter Time (HIN, LIN)		300		ns		



### **Thermal and Mechanical Characteristics**

Symbol	Description		Min Typ Max		Units	Conditions	
R <sub>th(J-B)</sub>	Thermal resistance, junction to mounting pad, each MOSFET	-	0.9	-	°C/W	Standard reflow-solder process	
R <sub>th(J-A)</sub>	Thermal resistance, junction to ambient, each MOSFET	-	40	1	°C/W	Mounted on 13.2cm2 of two-layer FR4 with 36 vias	

### **Input-Output Logic Level Table**



HIN	LIN	U,V,W
HI	HI	V+
LO	LO	0
HI	LO	**
LO	HI	*

<sup>\*</sup> V+ if motor current is flowing into VS, 0 if current is flowing out of VS into the motor winding \*\* Anti Shoot-through protection active (both HO and LO are OFF)



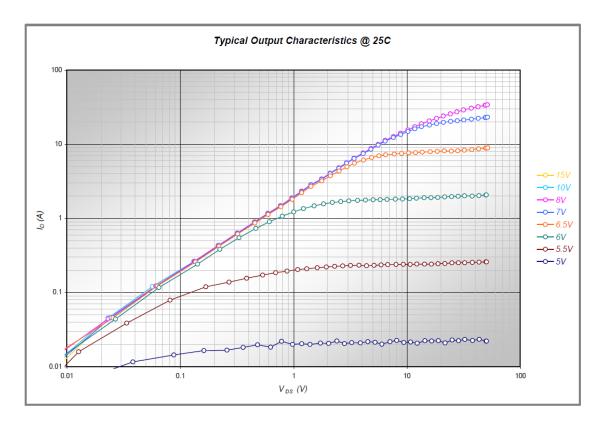


Figure 1 - MOS typical output characteristics at 25°C

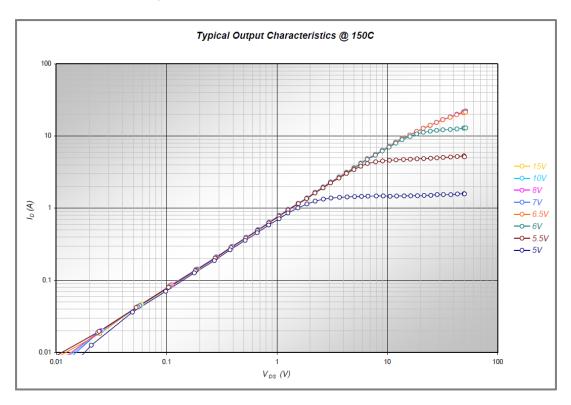


Figure 2 - MOS typical output characteristics at 25°C



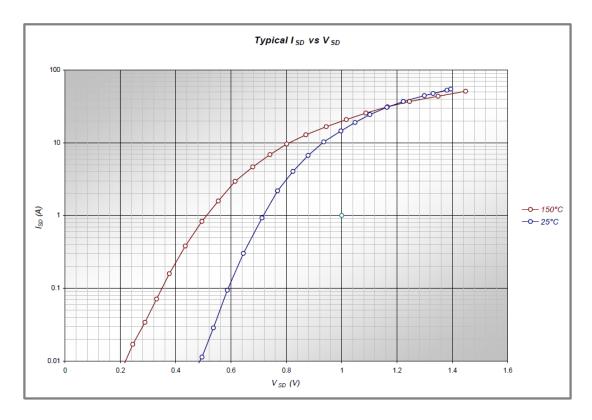


Figure 3 - MOS body diode typical characteristics at 25°C and 150°C

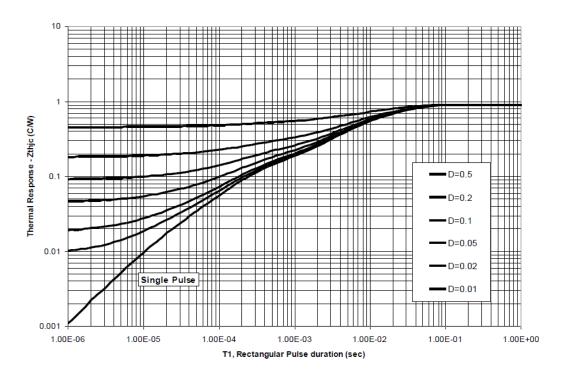


Figure 4 – module top surface typical thermal impedance



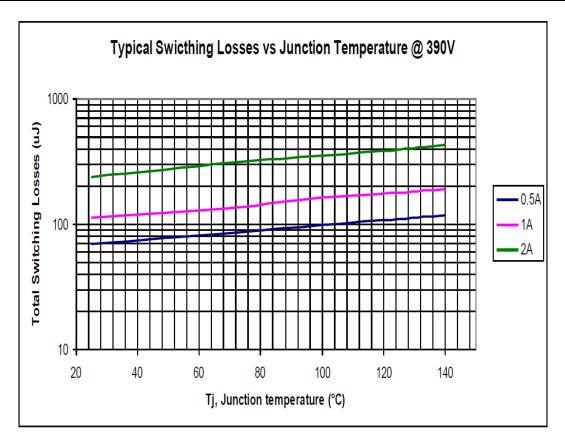


Figure 5 - Typical switching losses at 390V

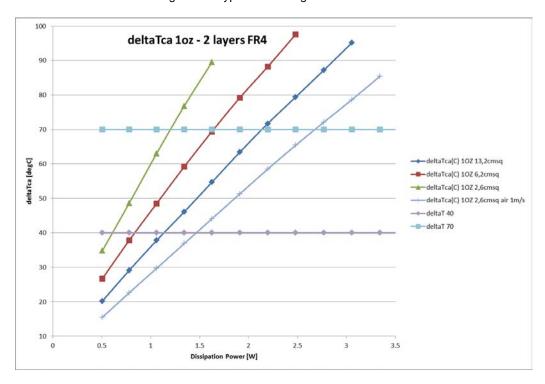


Figure 6 – typical delta temperature between case (no heat-sink) and ambient with 1oz FR4 vs. power dissipation in the module



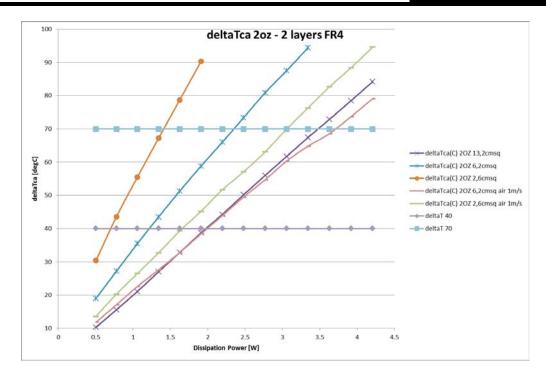


Figure 7 - typical delta temperature between case (no heat-sink) and ambient with 2oz FR4 vs. power dissipation in the module

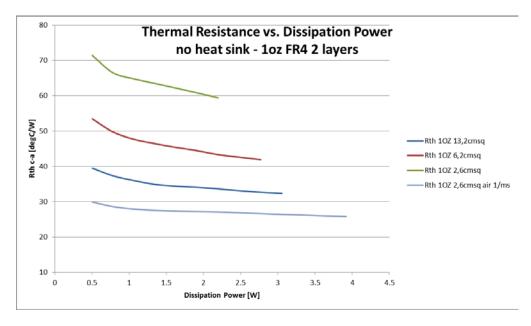


Figure 8 – Typical thermal resistance vs. power dissipation in the module (no heat sink) with 1oz FR4



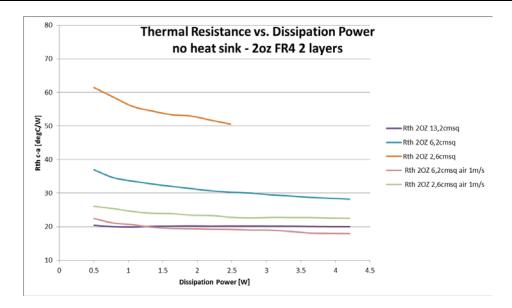


Figure 9 – Typical thermal resistance vs. power dissipation in the module (no heat sink) with 2oz FR4

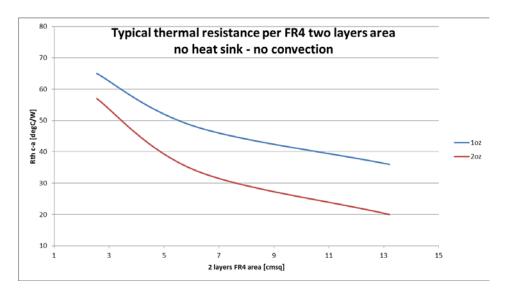


Figure 10 - Typical thermal resistance vs. area per module (no heat sink) with two layers FR4



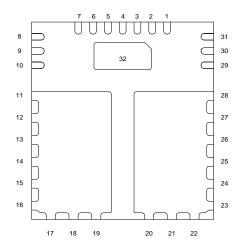
#### **Qualification†**

Qualification Level		Industrial <sup>††</sup> (per JEDEC JESD 47)			
Moisture Sensitivity Level		MSL3 <sup>†††</sup> (per IPC/JEDEC J-STD-020)			
ESD	Human Body Model	Class 1C (per JEDEC standard ANSI/ESDA/JEDEC JS-001)			
ESD	Machine Model	Class A (per EIA/JEDEC standard JESD22-A115)			
RoHS Compliant		Yes			

- Qualification standards can be found at International Rectifier's web site <a href="http://www.irf.com/">http://www.irf.com/</a> †
- Higher qualification ratings may be available should the user have such requirements. Please contact your †† International Rectifier sales representative for further information.
- Higher MSL ratings may be available for the specific package types listed here. Please contact your International ††† Rectifier sales representative for further information.

### **Module Pin-Out Description**

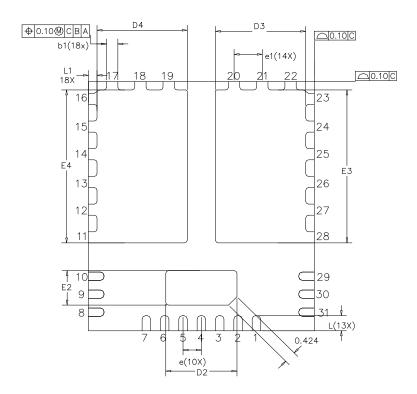
Pin	Name	Description
1, 4, 7, 32	СОМ	Low Side Gate Drive Return
2	VCC	15V Gate Drive Supply
3	HIN	Logic Input for High Side (Active High)
5	LIN	Logic Input for Low Side (Active Low)
6	DT	Dead time
8, 9, 10	V-	Low Side Source Connection
11 – 19	VS	Phase Output
20 – 28	V+	DC Bus
29 – 30	VS	Phase Output (-ve Bootstrap Cap Connection)
31	VB	High Side Floating Supply (+ve Bootstrap Cap Connection)



Exposed pad (Pin 32) has to be connected to COM for better electrical performance



## Package Outline IRSM808-105MH (Bottom View), 1 of 2

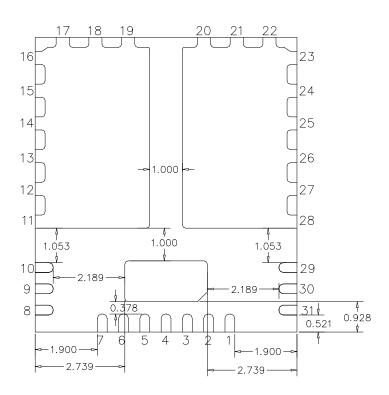


SYMBOL	DIMENSIONS IN MILLIMETER						
	MIN.	NOM.	MAX.				
Α	0.800	0.900	1.000				
A1	0.000	_	0.050				
А3	0.2	203 RE	=				
b	0.250	0.300	0.350				
b1	0.350	0.400	0.450				
D	7.900	8.000	8.100				
Ε	8.900	9.000	9.100				
D2	2.472	2.522	2.572				
E2	1.197	1.247	1.297				
D3	3.147	3.197	3.247				
ЕЗ	5.472	5.522	5.572				
D4	3.147	3.197	3.247				
E4	5.472	5.522	5.572				
е	0.0	650 BS	С				
e1	1.0	1.000 BSC					
e2	1.4	403 BS	С				
еЗ	2.	318 BS					
L	0.500	0.550	0.600				
L1	0.253	0.303	0.353				

Dimensions in mm



## Package Outline IRSM808-105MH (Bottom View), 2 of 2

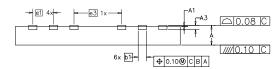


Dimensions in mm

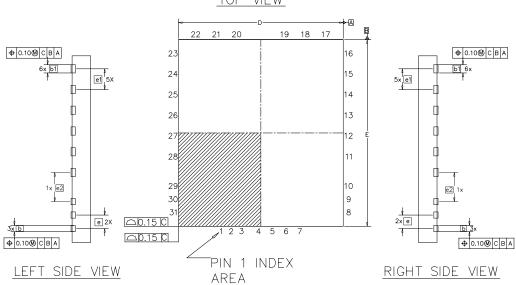


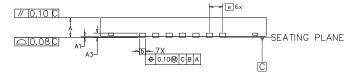
## Package Outline IRSM808-105MH (Top & Side View)

## BACK SIDE VIEW



#### TOP VIEW





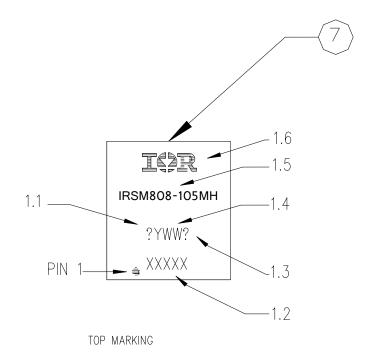
#### FRONT SIDE VIEW

귕	DIMENSIONS			E2	1.197	1.247	1.297	
SYMBOL	NAI	IN LLIMETE	D		D3	3.147	3.197	3.247
ĺν	IVII		./\		E3	5.472	5.522	5.572
	MIN.	NOM.	MAX.	1				
Α	0.800	0.900	1.000	1	D4	3.147	3.197	3.247
	0.600	0.900	1.000		E4	5.472	5 522	5.572
A1	0.000		0.050					
A3	0	203 RF	-	t	е	0.650 BSC		
7.0					- 1	1 1	000 BS	_
b	0.250	0.300	0.350		e1	1.4	100 R2	<u> </u>
b1	0.350	0.400	0.450	1	e2	1	403 BS	С
D	7.900	8.000	8.100	,	еЗ	2.318 BSC		С
E	8.900	9.000	9.100		L	0.500	0.550	0.600
D2	2.472	2.522	2.572	•	L1	0.253	0.303	0.353
				-				

Dimensions in mm



### **Top Marking**



- NOTES, MARKING:
  1.1) SITE CODE: X
  1.2) LAST 4 CHARACTER OF SPN/NANA CODE: XXXX
  1.3) LEADFREE INDICATOR: P

- 1.4) DATE CODE: YWW 1.5) PART NUMBER: IRSM607-105MH

- 1.6) IR LOGO 1.7) MEDIUM: 1.7.1) TOP:LASER 1.7.2) BOTTOM: NONE



### **Typical Application Connection IRS808-105MH**

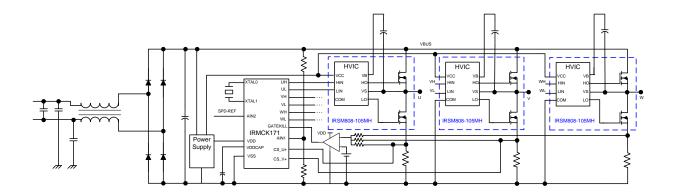
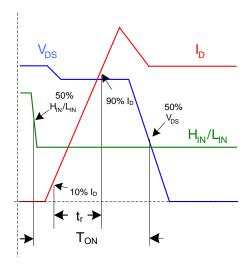


Figure 1: Typical Application Connection

- Bus capacitors should be mounted as close to the module bus terminals as possible to reduce ringing and EMI problems. Additional high frequency ceramic capacitor mounted close to the module pins will further improve performance.
- In order to provide a good decoupling between VCC-VSS abd VB-VS terminals, the capaciotrs shown connected at these terminals should be located very close to the module pins. Additional high frequency capacitors, typically 0.1uF, are recommended.
- Value of the boot-strap capacitors depends upon the switching frequency. Their selection should be made based on IR Design tip DT04-4 or application note AN-1044.





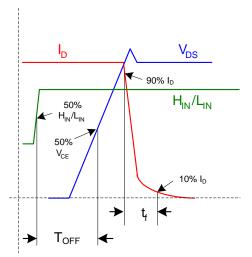


Figure 3a. Input to Output propagation turn-on delay time.

Figure 3b. Input to Output propagation turn-off delay

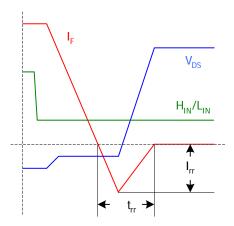


Figure 3c. Diode Reverse Recovery





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